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FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

1793.1242	APPLICATION NO.		
FIRST NAMED INVENTOR			
Jong-tae AN et al.			
FILING DATE	GROUP ART UNIT		

April 22, 2004

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EXAMINER	/	Henok Heyi/	 19/2007

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.